

Tutorial of the new endpoints, bootstrap and k -sample statistic

Hsin-wen Chang*

April 13, 2022

1 Testing under biased sampling and crossing CDFs

1.1 Biased sampling and crossing CDFs

Instead of observing directly from F_j , the observed samples $\{X_{ij}, i = 1, \dots, n_j\}$ ($j = 1, 2$) are size-biased and i.i.d. from

$$G_j(t) = \int_{-\infty}^t \frac{w_j(u)}{W_j} dF_j(u),$$

where $w_j(t) > 0$ are known biasing functions depending on the size t of the datum, and $W_j = \int_{-\infty}^{\infty} w_j(u) dF_j(u) < \infty$ are the normalizing constants. Note that a constant biasing function yields the special case of no biased sampling. The NPMLE $F_j(t)$ (see, e.g., [Owen, 2001](#), Ch. 6.1) is given by $\hat{F}_j(t) \equiv \sum_{i=1}^{n_j} \hat{p}_{ij} I_{X_{ij} \leq t}$, where $\hat{p}_{ij} = \hat{W}_j / \{n_j w_j(X_{ij})\}$ and $\hat{W}_j = n_j / \sum_{i=1}^{n_j} (1/w_j(X_{ij}))$. Let $\hat{D}(t) = \hat{F}_1(t) - \hat{F}_2(t)$ denote the estimate for the quantity we are interested in: $F_1(t) - F_2(t)$ for $t \in [\tau_1, \tau_2]$.

To test for H_0 , we start with an AD-type statistic:

$$B_n = n \int_{\tau_1}^{\tau_2} \frac{\hat{D}^2(t)}{\hat{\theta}(t, t)} d\hat{H}(t),$$

where $n = n_1 + n_2$, $\hat{H}(t) = \{n_1 \hat{F}_1(t) + n_2 \hat{F}_2(t)\} / n$ is an estimate for the common CDF F_0 under H_0 , $\hat{\theta}(s, t) = \sum_{j=1}^2 \sum_{i=1}^{n_j} \hat{W}_j^2 \{I_{X_{ij} \leq s} - \hat{H}(s)\} \{I_{X_{ij} \leq t} - \hat{H}(t)\} / \{n \kappa_j^2 w_j^2(X_{ij})\}$, $\kappa_j = n_j / n$, and we adopt the convention that $0/0 = 0$. Note that the denominator of the integrand of B_n is an estimate of the asymptotic variance of $\sqrt{n} \hat{D}(t)$; this formulation takes into account the fact that the integrand of a usual AD statistic is studentized. An alternative is to simply replacing the elements in a usual two-sample AD statistic

*Institute of Statistical Science, Academia Sinica, Taipei 11529, Taiwan.

(Pettitt, 1976) by their counterparts in biased-sampling settings, leading to

$$A_n = \frac{n_1 n_2}{n} \int_{\tau_1}^{\tau_2} \frac{\hat{D}^2(t)}{\hat{H}(t) \{1 - \hat{H}(t)\}} d\hat{H}(t).$$

Unfortunately, this statistic did not perform well in our simulation study; this shows the importance of studentizing the integrand properly in an integral-type statistic.

Although both B_n and A_n incorporate variance of the estimated quantity of interest $\hat{D}(t)$, they do not consider the correlations between $\hat{D}(s)$ and $\hat{D}(t)$ for different s and t . To incorporate the correlations, consider replacing the integrand of B_n by an estimate of the Mahalanobis distance between $\sqrt{n}[\hat{F}_1(s), \hat{F}_1(t)]^T$ and $\sqrt{n}[\hat{F}_2(s), \hat{F}_2(t)]^T$: $M_n^B(s, t) \equiv n[\hat{D}(s), \hat{D}(t)]\hat{\Theta}^{-1}(s, t)[\hat{D}(s), \hat{D}(t)]^T$ and changing the single integral into double integrals, where

$$\hat{\Theta}(s, t) = \begin{bmatrix} \hat{\theta}(s, s) & \hat{\theta}(s, t) \\ \hat{\theta}(t, s) & \hat{\theta}(t, t) \end{bmatrix}.$$

This can be seen as a bivariate generalization of B_n . A similar generalization of A_n can be achieved by using the integrand $M_n^A(s, t) \equiv n[\hat{D}(s), \hat{D}(t)]\hat{\Psi}^{-1}(s, t)[\hat{D}(s), \hat{D}(t)]^T$, where

$$\hat{\Psi}(s, t) = \begin{bmatrix} \hat{H}(s) \{1 - \hat{H}(s)\} & \hat{H}(s) \{1 - \hat{H}(t)\} \\ \hat{H}(s) \{1 - \hat{H}(t)\} & \hat{H}(t) \{1 - \hat{H}(t)\} \end{bmatrix}.$$

The resulting statistics

$$BA_n = \kappa_1 \kappa_2 \int \int_{\substack{s, t \in [\tau_1, \tau_2] \\ s < t}} M_n^A(s, t) d\hat{H}(s) d\hat{H}(t) \text{ and} \\ BB_n = \int \int_{\substack{s, t \in [\tau_1, \tau_2] \\ s < t}} M_n^B(s, t) d\hat{H}(s) d\hat{H}(t)$$

can be viewed as testing the bivariate hypotheses H'_0 versus H'_1 . Although this testing problem is equivalent to testing the univariate H_0 versus H_1 , the statistics for the bivariate hypotheses incorporate the (pairwise) interactions among $\hat{D}(t)$ at different t values, and hence may have better power in detecting difference between the underlying CDFs.

Remark 2. The condition $0 < F_0(t_1) < F_0(t_2) < 1$ is needed for $H(s, t)$ and $\Theta(s, t)$ to be invertable. This suggests a data-driven rule for τ_1 and τ_2 : $\tau_1 = \inf\{t : \hat{F}_1(t) > 0 \text{ and } \hat{F}_2(t) > 0\}$ and $\tau_2 = \sup\{t : \hat{F}_1(t) < 1 \text{ and } \hat{F}_2(t) < 1\}$. This is what we use in the later simulation runs and data analysis.

The limiting distributions need to be estimated because they are not distribution-free. This can be done using a similar multiplier bootstrap approach as the one

proposed in Chang et al. (2016) for biased sampling data. Specifically, it suffices to bootstrap the key component $\hat{D}(t)$ in the statistics by $D^*(t) = D_1^*(t) - D_2^*(t)$, where $D_j^*(t) = \sum_{i=1}^{n_j} \xi_{ij} \hat{p}_{ij} \{I_{X_{ij} \leq t} - \hat{H}(t)\}$ and ξ_{ij} s are (t) standard normal random variables independent of the data. The bootstrap procedure is given as follows.

- (a) Given each draw of the multipliers $\{\xi_{ij}, i = 1, \dots, n_j, j = 1, 2\}$, compute a value for each of

$$\begin{aligned} A_n^* &= \frac{n_1 n_2}{n} \int_{\tau_1}^{\tau_2} \frac{D^{*2}(t)}{\hat{H}(t) \{1 - \hat{H}(t)\}} d\hat{H}(t), \quad B_n^* = n \int_{\tau_1}^{\tau_2} \frac{D^{*2}(t)}{\hat{\theta}(t, t)} d\hat{H}(t), \\ BA_n^* &= \kappa_1 \kappa_2 \int \int_{\substack{s, t \in [\tau_1, \tau_2] \\ s < t}} n[D^*(s), D^*(t)] \hat{\Psi}^{-1}(s, t) [D^*(s), D^*(t)]^T d\hat{H}(s) d\hat{H}(t), \text{ and} \\ BB_n^* &= \int \int_{\substack{s, t \in [\tau_1, \tau_2] \\ s < t}} n[D^*(s), D^*(t)] \hat{\Theta}^{-1}(s, t) [D^*(s), D^*(t)]^T d\hat{H}(s) d\hat{H}(t). \end{aligned}$$

Alternatively, change $\hat{\theta}(s, t)$ in B_n^* and BB_n^* above to $\hat{\theta}^*(s, t) = \sum_{j=1}^2 \hat{\theta}_j^*(s, t)$, where $\hat{\theta}_j^*(s, t)$ is the sample covariance of $V_{ij}^*(t) = \xi_{ij} \hat{W}_j [I_{X_{ij} \leq t} - \hat{H}(t)] / \{\sqrt{\kappa_j} w_j(X_{ij})\}$.

1.2 k -sample statistic

$$B_n = \int_{\tau_1}^{\tau_2} \widehat{\text{SSB}}(t) d\hat{H}(t),$$

where

$$\widehat{\text{SSB}}(t) = \sum_{j=1}^k \hat{w}_j(t) \left\{ \frac{\hat{\Psi}_j(t)}{\sqrt{\hat{w}_j(t)}} - \check{\Psi}(t) \right\}^2, \quad (1)$$

$\check{\Psi}(t) = \sum_{j=1}^k \sqrt{\hat{w}_j(t)} \hat{\Psi}_j(t)$, $\hat{\Psi}_j(t) = \sqrt{n} \{\hat{F}_j - \hat{H}\}(t) / \sqrt{\hat{\theta}_j(t, t)}$, $\hat{\theta}_j(s, t) = \sum_{i=1}^{n_j} \hat{W}_j^2 \{I_{X_{ij} \leq s} - \hat{H}(s)\} \{I_{X_{ij} \leq t} - \hat{H}(t)\} / \{n \kappa_j^2 w_j^2(X_{ij})\}$, and the time-varying group-specific weights $\hat{w}_j(t) \propto 1/\hat{\theta}_j(t, t)$, $j = 1, \dots, k$. The weights $w_j(t)$ are normalized to sum to 1. That is, $w_j(t) = \prod_{g \in E_j} \hat{\theta}_g(t, t) / \hat{\phi}(t) > 0$, where $E_j = \{1, \dots, k\} \setminus \{j\}$ and $\hat{\phi}(t) = \sum_{l=1}^k \prod_{g \in E_l} \hat{\theta}_g(t, t)$. This k -sample statistic reduces to the B_n in Section 1.1 when $k = 2$. A data-driven rule for τ_1 and τ_2 : $\tau_1 = \inf\{t : \hat{F}_j(t) > 0 \text{ for all } j = 1, \dots, k\}$ and $\tau_2 = \sup\{t : \hat{F}_j(t) < 1 \text{ for all } j = 1, \dots, k\}$.

For calibration, again we use a similar multiplier bootstrap method as in Section 1.1, based on sampling i.i.d. standard normal random variables (multipliers) ξ_{ij} s independent of the data. Specifically, it suffices to bootstrap the key component $\widehat{\text{SSB}}(t)$ in B_n by $\widehat{\text{SSB}}^*(t)$, where

$$\widehat{\text{SSB}}^*(t) = \sum_{j=1}^k \hat{w}_j(t) \left\{ \frac{\hat{\Psi}_j^*(t)}{\sqrt{\hat{w}_j(t)}} - \check{\Psi}^*(t) \right\}^2,$$

$\hat{\Psi}_j^*(t) = \sqrt{n}D_j^*(t)/\sqrt{\hat{\theta}_j^*(t, t)}$, $\hat{\theta}_j^*(t, t)$ is the sample variance of $V_{ij}^* = \xi_{ij}\hat{W}_j[I_{X_{ij} \leq t} - \hat{H}(t)]/\{\sqrt{\kappa_j}w_j(X_{ij})\}$, and $\check{\Psi}^*(t) = \sum_{j=1}^k \sqrt{\hat{w}_j(t)}\hat{\Psi}_j^*(t)$. The resulting bootstrap for B_n is $B_n^* = \sup_{a \in [\alpha_1, \alpha_2]} \widehat{\text{SSB}}^*(t)$. To calibrate the test, we compare the upper α -quantile of the K_n^* values obtained from $B = 1000$ bootstrap samples (as in Section 1.1) with our test statistic B_n .

References

- Chang, H., El Barmi, H., and McKeague, I. W. (2016). Tests for stochastic ordering under biased sampling. *Journal of Nonparametric Statistics*, 28(4):659–682.
- Owen, A. B. (2001). *Empirical Likelihood*. Chapman & Hall/CRC, Boca Raton.
- Pettitt, A. N. (1976). A two-sample anderson-darling rank statistic. *Biometrika*, 63:161–168.